

BIPOLAR ANALOG INTEGRATED CIRCUIT

μ PC2400A Series

THREE TERMINAL LOW DROPOUT VOLTAGE REGULATOR

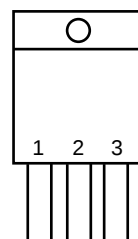
DESCRIPTION

μ PC2400A Series are low dropout regulators which have 1 A capable for the output current.
These ICs are built-in the saturation protection circuit of the output transistor.

FEATURES

- Built-in the saturation protection circuit of the output transistor.
- The capability of output current is 1 A
- High accuracy of output voltage.
 $|\Delta V_o| \leq \pm 2\% (T_J = 25^\circ\text{C})$
 $|\Delta V_o| \leq \pm 3\% (0^\circ\text{C} \leq T_J \leq 125^\circ\text{C})$
- Low dropout voltage.
 $V_{DIF} \leq 1\text{ V} (I_o \leq 1\text{ A}, T_J \leq 125^\circ\text{C})$
- Built-in overcurrent protection circuit, thermal shut-down circuit.
- Built-in Safe Operating Area protection circuit.
- Compatible for μ PC2400 Series.

CONNECTION DIAGRAM (TOP VIEW)

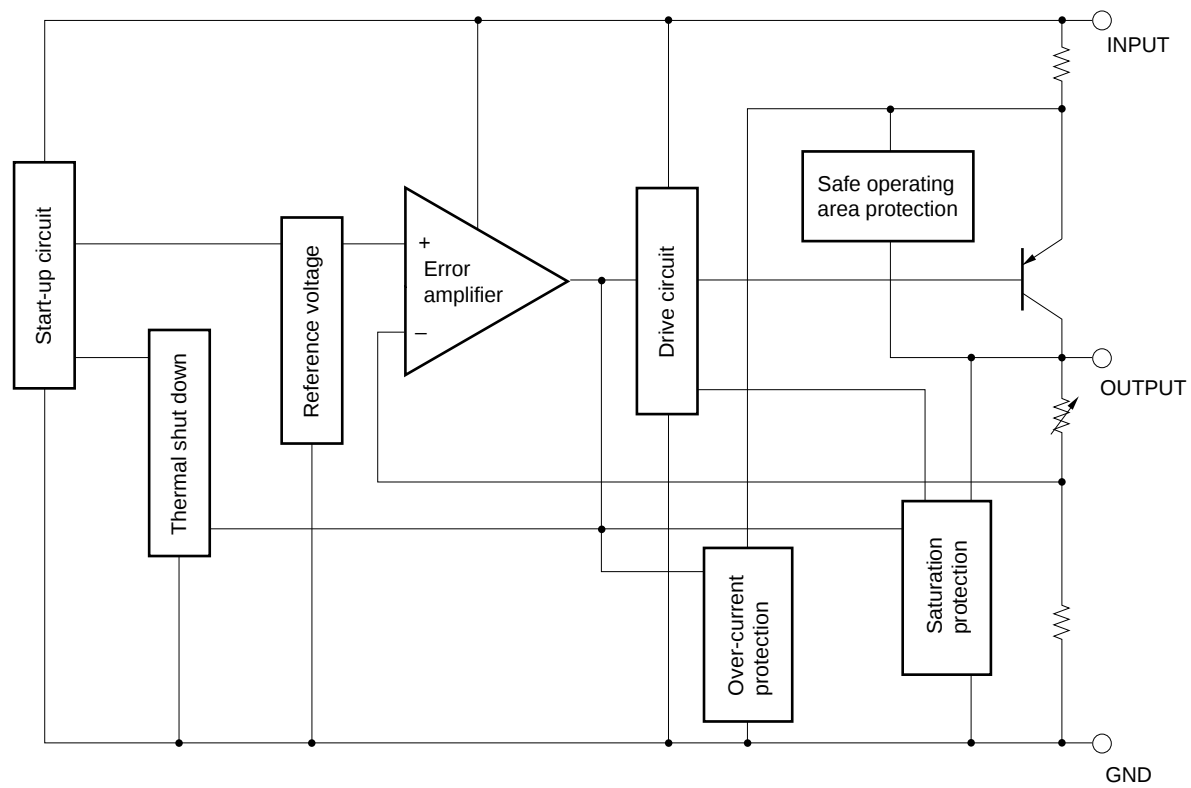


1: INPUT
2: GND
3: OUTPUT

ORDERING INFORMATION

Output Voltage	Type Number	Package
5 V	μ PC2405AHF	MP-45G (Isolated TO-220)
6 V	μ PC2406AHF	
7 V	μ PC2407AHF	
8 V	μ PC2408AHF	
9 V	μ PC2409AHF	
10 V	μ PC2410AHF	
12 V	μ PC2412AHF	
15 V	μ PC2415AHF	
18 V	μ PC2418AHF	

BLOCK DIAGRAM

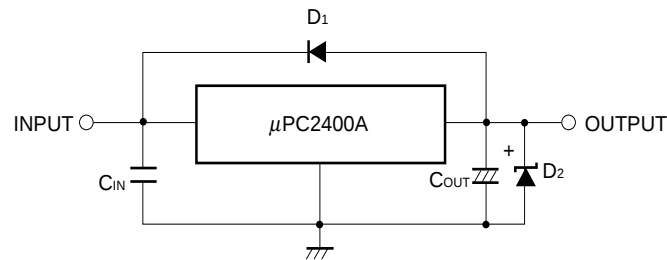


ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^{\circ}\text{C}$, Unless otherwise specified.)

PARAMETER	SYMBOL	RATING	UNIT
Input Voltage	V_{IN}	36	V
Internal Power Dissipation	$P_{T(T_C = 25\text{ }^{\circ}\text{C})}$	15 Note	W
Operating Ambient Temperature Range	T_A	-20 to +85	$^{\circ}\text{C}$
Operating Junction Temperature Range	T_J	-20 to +150	$^{\circ}\text{C}$
Storage Temperature Range	T_{stg}	-55 to +150	$^{\circ}\text{C}$
Thermal Resistance (Junction to Case)	$R_{th(J - C)}$	5.0	$^{\circ}\text{C/W}$
Thermal Resistance (Junction to Ambient)	$R_{th(J - A)}$	65	$^{\circ}\text{C/W}$

Note Internally limited

TYPICAL CONNECTION



C_{IN} : 0.1 to 0.47 μF .

C_{OUT} : More than 47 μF .

D_1 : Need for $V_O > V_{IN}$.

D_2 : Need for $V_O < \text{GND}$.

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	TYPE NUMBER	MIN.	TYP.	MAX.	UNIT
Input Voltage	V_{IN}	$\mu\text{PC2405AHF}$	6	9	20	V
		$\mu\text{PC2406AHF}$	7	10	21	
		$\mu\text{PC2407AHF}$	8	11	22	
		$\mu\text{PC2408AHF}$	9	13	23	
		$\mu\text{PC2409AHF}$	10	14	24	
		$\mu\text{PC2410AHF}$	11	15	25	
		$\mu\text{PC2412AHF}$	13	18	27	
		$\mu\text{PC2415AHF}$	16	22	27	
		$\mu\text{PC2418AHF}$	19	25	28	
Output Current	I_O	All	0		1	A
Operating Ambient Temperature Range	T_A	All	-20		+85	$^{\circ}\text{C}$
Operating Junction Temperature Range	T_J	All	-20		+125	$^{\circ}\text{C}$

ELECTRICAL CHARACTERISTICS

μPC2405A ($V_{IN} = 9\text{ V}$, $I_O = 500\text{ mA}$, $T_J = 25\text{ }^{\circ}\text{C}$, Unless otherwise specified)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Output Voltage	V_O	4.9	5.0	5.1	V	
		4.85		5.15		$6\text{ V} \leq V_{IN} \leq 20\text{ V}$, $5\text{ mA} \leq I_O \leq 500\text{ mA}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
		4.85		5.15		$5\text{ mA} \leq I_O \leq 1\text{ A}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
Line Regulation	REG_{IN}		6	50	mV	$6.5\text{ V} \leq V_{IN} \leq 20\text{ V}$
Load Regulation	REG_L		3	50	mV	$5\text{ mA} \leq I_O \leq 1\text{ A}$
Quiescent Current	I_{BIAS}		2.3	3.2	mA	$I_O = 0$
			9	60		$I_O = 1\text{ A}$
Start-up Current	$I_{BIAS(S)}$			15	mA	$V_{IN} = 4.5\text{ V}$, $I_O = 0\text{ mA}$
				75		$V_{IN} = 4.5\text{ V}$, $I_O = 1\text{ A}$
Quiescent Current Change	ΔI_{BIAS}			20	mA	$6.5\text{ V} \leq V_{IN} \leq 20\text{ V}$, $I_O = 1\text{ A}$
Output Noise Voltage	V_n		90		μV_{rms}	$10\text{ Hz} \leq f \leq 100\text{ kHz}$
Ripple Rejection	$R \cdot R$	59	64		dB	$f = 120\text{ Hz}$, $6.5\text{ V} \leq V_{IN} \leq 16.5\text{ V}$
Dropout Voltage	V_{DIF}		0.5	1.0	V	$I_O = 1\text{ A}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
Short Circuit Current	I_{short}		1.2		A	$V_{IN} = 20\text{ V}$
Peak Output Current	I_{Opeak}	1.65	2.2	3.1	A	
Temperature Coefficient of Output Voltage	$\Delta V_O / \Delta T$		-0.4		mV/ $^{\circ}\text{C}$	$I_O = 5\text{ mA}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$

μPC2406A ($V_{IN} = 10\text{ V}$, $I_O = 500\text{ mA}$, $T_J = 25\text{ }^{\circ}\text{C}$, Unless otherwise specified)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Output Voltage	V_O	5.88	6.0	6.12	V	
		5.82		6.18		$7\text{ V} \leq V_{IN} \leq 21\text{ V}$, $5\text{ mA} \leq I_O \leq 500\text{ mA}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
		5.82		6.18		$5\text{ mA} \leq I_O \leq 1\text{ A}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
Line Regulation	REG_{IN}		7	60	mV	$7.5\text{ V} \leq V_{IN} \leq 21\text{ V}$
Load Regulation	REG_L		4	60	mV	$5\text{ mA} \leq I_O \leq 1\text{ A}$
Quiescent Current	I_{BIAS}		2.3	3.2	mA	$I_O = 0$
			9	60		$I_O = 1\text{ A}$
Start-up Current	$I_{BIAS(S)}$			15	mA	$V_{IN} = 5.5\text{ V}$, $I_O = 0\text{ mA}$
				75		$V_{IN} = 5.5\text{ V}$, $I_O = 1\text{ A}$
Quiescent Current Change	ΔI_{BIAS}			20	mA	$7.5\text{ V} \leq V_{IN} \leq 21\text{ V}$, $I_O = 1\text{ A}$
Output Noise Voltage	V_n		110		μV_{rms}	$10\text{ Hz} \leq f \leq 100\text{ kHz}$
Ripple Rejection	$R \cdot R$	58	63		dB	$f = 120\text{ Hz}$, $7.5\text{ V} \leq V_{IN} \leq 17.5\text{ V}$
Dropout Voltage	V_{DIF}		0.5	1.0	V	$I_O = 1\text{ A}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
Short Circuit Current	I_{short}		1.2		A	$V_{IN} = 21\text{ V}$
Peak Output Current	I_{Opeak}	1.65	2.2	3.1	A	
Temperature Coefficient of Output Voltage	$\Delta V_O / \Delta T$		0.4		mV/ $^{\circ}\text{C}$	$I_O = 5\text{ mA}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$

μ PC2407A ($V_{IN} = 11\text{ V}$, $I_O = 500\text{ mA}$, $T_J = 25\text{ }^\circ\text{C}$, Unless otherwise specified)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Output Voltage	V_O	6.86	7.0	7.14	V	
		6.79		7.21		$8\text{ V} \leq V_{IN} \leq 22\text{ V}$, $5\text{ mA} \leq I_O \leq 500\text{ mA}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
		6.79		7.21		$5\text{ mA} \leq I_O \leq 1\text{ A}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
Line Regulation	REG_{IN}		8	70	mV	$8.5\text{ V} \leq V_{IN} \leq 22\text{ V}$
Load Regulation	REG_L		4	70	mV	$5\text{ mA} \leq I_O \leq 1\text{ A}$
Quiescent Current	I_{BIAS}		2.3	3.2	mA	$I_O = 0$
			9	60		$I_O = 1\text{ A}$
Start-up Current	$I_{BIAS(S)}$			15	mA	$V_{IN} = 6.5\text{ V}$, $I_O = 0\text{ mA}$
				75		$V_{IN} = 6.5\text{ V}$, $I_O = 1\text{ A}$
Quiescent Current Change	ΔI_{BIAS}			20	mA	$8.5\text{ V} \leq V_{IN} \leq 22\text{ V}$, $I_O = 1\text{ A}$
Output Noise Voltage	V_n		130		μV_{rms}	$10\text{ Hz} \leq f \leq 100\text{ kHz}$
Ripple Rejection	$R \cdot R$	57	62		dB	$f = 120\text{ Hz}$, $8.5\text{ V} \leq V_{IN} \leq 18.5\text{ V}$
Dropout Voltage	V_{DIF}		0.5	1.0	V	$I_O = 1\text{ A}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
Short Circuit Current	I_{short}		1.2		A	$V_{IN} = 22\text{ V}$
Peak Output Current	I_{Opeak}	1.65	2.2	3.1	A	
Temperature Coefficient of Output Voltage	$\Delta V_O / \Delta T$		0.4		mV/ $^\circ\text{C}$	$I_O = 5\text{ mA}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$

 μ PC2408A ($V_{IN} = 13\text{ V}$, $I_O = 500\text{ mA}$, $T_J = 25\text{ }^\circ\text{C}$, Unless otherwise specified)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Output Voltage	V_O	7.85	8.0	8.15	V	
		7.75		8.25		$9\text{ V} \leq V_{IN} \leq 23\text{ V}$, $5\text{ mA} \leq I_O \leq 500\text{ mA}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
		7.75		8.25		$5\text{ mA} \leq I_O \leq 1\text{ A}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
Line Regulation	REG_{IN}		9	80	mV	$9.5\text{ V} \leq V_{IN} \leq 23\text{ V}$
Load Regulation	REG_L		5	80	mV	$5\text{ mA} \leq I_O \leq 1\text{ A}$
Quiescent Current	I_{BIAS}		2.3	3.2	mA	$I_O = 0$
			9	60		$I_O = 1\text{ A}$
Start-up Current	$I_{BIAS(S)}$			15	mA	$V_{IN} = 7.5\text{ V}$, $I_O = 0\text{ mA}$
				75		$V_{IN} = 7.5\text{ V}$, $I_O = 1\text{ A}$
Quiescent Current Change	ΔI_{BIAS}			20	mA	$9.5\text{ V} \leq V_{IN} \leq 23\text{ V}$, $I_O = 1\text{ A}$
Output Noise Voltage	V_n		150		μV_{rms}	$10\text{ Hz} \leq f \leq 100\text{ kHz}$
Ripple Rejection	$R \cdot R$	56	61		dB	$f = 120\text{ Hz}$, $9.5\text{ V} \leq V_{IN} \leq 19.5\text{ V}$
Dropout Voltage	V_{DIF}		0.5	1.0	V	$I_O = 1\text{ A}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
Short Circuit Current	I_{short}		1.2		A	$V_{IN} = 23\text{ V}$
Peak Output Current	I_{Opeak}	1.6	2.2	3.05	A	
Temperature Coefficient of Output Voltage	$\Delta V_O / \Delta T$		0.5		mV/ $^\circ\text{C}$	$I_O = 5\text{ mA}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$

μ PC2409A ($V_{IN} = 14\text{ V}$, $I_O = 500\text{ mA}$, $T_J = 25\text{ }^\circ\text{C}$, Unless otherwise specified)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Output Voltage	V_O	8.82	9.0	9.18	V	
		8.73		9.27		$10\text{ V} \leq V_{IN} \leq 24\text{ V}$, $5\text{ mA} \leq I_O \leq 500\text{ mA}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
		8.73		9.27		$5\text{ mA} \leq I_O \leq 1\text{ A}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
Line Regulation	REG_{IN}		11	90	mV	$10.5\text{ V} \leq V_{IN} \leq 24\text{ V}$
Load Regulation	REG_L		5	90	mV	$5\text{ mA} \leq I_O \leq 1\text{ A}$
Quiescent Current	I_{BIAS}		2.4	3.2	mA	$I_O = 0$
			9	60		$I_O = 1\text{ A}$
Start-up Current	$I_{BIAS(S)}$			15	mA	$V_{IN} = 8.5\text{ V}$, $I_O = 0\text{ mA}$
				75		$V_{IN} = 8.5\text{ V}$, $I_O = 1\text{ A}$
Quiescent Current Change	ΔI_{BIAS}			20	mA	$10.5\text{ V} \leq V_{IN} \leq 24\text{ V}$, $I_O = 1\text{ A}$
Output Noise Voltage	V_n		170		μV_{rms}	$10\text{ Hz} \leq f \leq 100\text{ kHz}$
Ripple Rejection	$R \cdot R$	55	60		dB	$f = 120\text{ Hz}$, $10.5\text{ V} \leq V_{IN} \leq 20.5\text{ V}$
Dropout Voltage	V_{DIF}		0.5	1.0	V	$I_O = 1\text{ A}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
Short Circuit Current	I_{short}		1.0		A	$V_{IN} = 24\text{ V}$
Peak Output Current	I_{Opeak}	1.6	2.2	3.05	A	
Temperature Coefficient of Output Voltage	$\Delta V_O/\Delta T$		0.9		mV/ $^\circ\text{C}$	$I_O = 5\text{ mA}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$

μ PC2410A ($V_{IN} = 15\text{ V}$, $I_O = 500\text{ mA}$, $T_J = 25\text{ }^\circ\text{C}$, Unless otherwise specified)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Output Voltage	V_O	9.8	10	10.2	V	
		9.7		10.3		$11\text{ V} \leq V_{IN} \leq 25\text{ V}$, $5\text{ mA} \leq I_O \leq 500\text{ mA}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
		9.7		10.3		$5\text{ mA} \leq I_O \leq 1\text{ A}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
Line Regulation	REG_{IN}		12	100	mV	$11.5\text{ V} \leq V_{IN} \leq 25\text{ V}$
Load Regulation	REG_L		6	100	mV	$5\text{ mA} \leq I_O \leq 1\text{ A}$
Quiescent Current	I_{BIAS}		2.4	3.2	mA	$I_O = 0$
			9	60		$I_O = 1\text{ A}$
Start-up Current	$I_{BIAS(S)}$			15	mA	$V_{IN} = 9.5\text{ V}$, $I_O = 0\text{ mA}$
				75		$V_{IN} = 9.5\text{ V}$, $I_O = 1\text{ A}$
Quiescent Current Change	ΔI_{BIAS}			20	mA	$11.5\text{ V} \leq V_{IN} \leq 25\text{ V}$, $I_O = 1\text{ A}$
Output Noise Voltage	V_n		190		μV_{rms}	$10\text{ Hz} \leq f \leq 100\text{ kHz}$
Ripple Rejection	$R \cdot R$	54	59		dB	$f = 120\text{ Hz}$, $11.5\text{ V} \leq V_{IN} \leq 21.5\text{ V}$
Dropout Voltage	V_{DIF}		0.5	1.0	V	$I_O = 1\text{ A}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$
Short Circuit Current	I_{short}		1.0		A	$V_{IN} = 25\text{ V}$
Peak Output Current	I_{Opeak}	1.6	2.2	3.05	A	
Temperature Coefficient of Output Voltage	$\Delta V_O/\Delta T$		0.8		mV/ $^\circ\text{C}$	$I_O = 5\text{ mA}$, $0\text{ }^\circ\text{C} \leq T_J \leq 125\text{ }^\circ\text{C}$

μPC2412A ($V_{IN} = 18\text{ V}$, $I_O = 500\text{ mA}$, $T_J = 25\text{ }^{\circ}\text{C}$, Unless otherwise specified)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Output Voltage	V_O	11.75	12	12.25	V	
		11.65		12.35		$13\text{ V} \leq V_{IN} \leq 27\text{ V}$, $5\text{ mA} \leq I_O \leq 500\text{ mA}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
		11.65		12.35		$5\text{ mA} \leq I_O \leq 1\text{ A}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
Line Regulation	REG_{IN}		14	120	mV	$14\text{ V} \leq V_{IN} \leq 27\text{ V}$
Load Regulation	REG_L		7	120	mV	$5\text{ mA} \leq I_O \leq 1\text{ A}$
Quiescent Current	I_{BIAS}		2.4	3.2	mA	$I_O = 0$
			10	60		$I_O = 1\text{ A}$
Start-up Current	$I_{BIAS(S)}$			15	mA	$V_{IN} = 11.5\text{ V}$, $I_O = 0\text{ mA}$
				75		$V_{IN} = 11.5\text{ V}$, $I_O = 1\text{ A}$
Quiescent Current Change	ΔI_{BIAS}			20	mA	$14\text{ V} \leq V_{IN} \leq 27\text{ V}$, $I_O = 1\text{ A}$
Output Noise Voltage	V_n		230		μV_{rms}	$10\text{ Hz} \leq f \leq 100\text{ kHz}$
Ripple Rejection	$R \cdot R$	53	58		dB	$f = 120\text{ Hz}$, $14\text{ V} \leq V_{IN} \leq 24\text{ V}$
Dropout Voltage	V_{DIF}		0.5	1.0	V	$I_O = 1\text{ A}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
Short Circuit Current	I_{short}		0.8		A	$V_{IN} = 27\text{ V}$
Peak Output Current	I_{Opeak}	1.58	2.2	3.03	A	
Temperature Coefficient of Output Voltage	$\Delta V_O / \Delta T$		0.8		mV/ $^{\circ}\text{C}$	$I_O = 5\text{ mA}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$

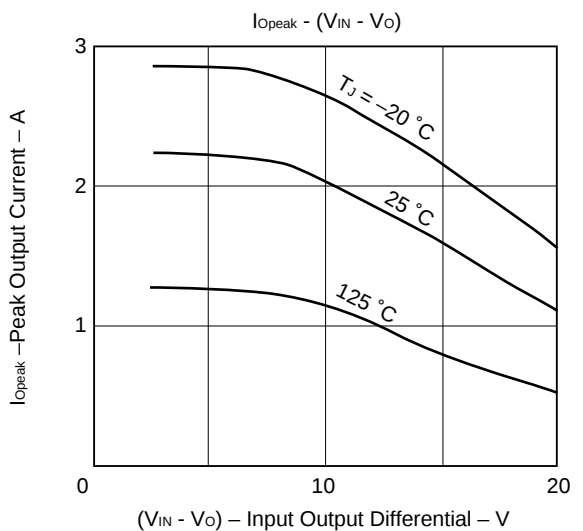
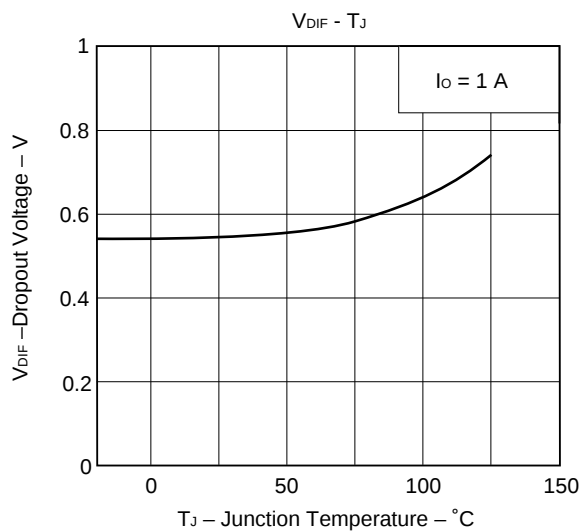
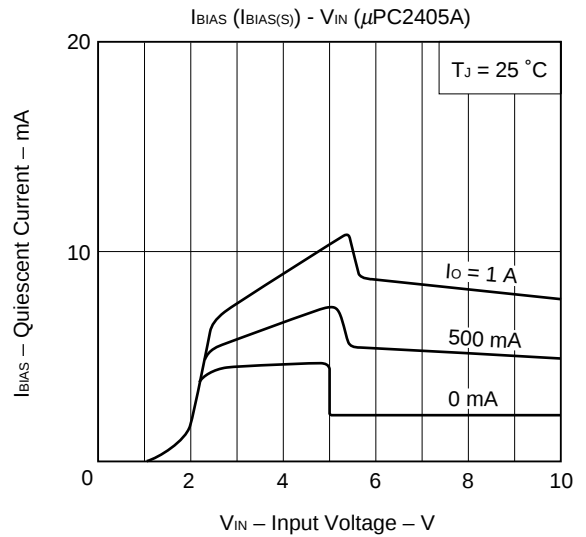
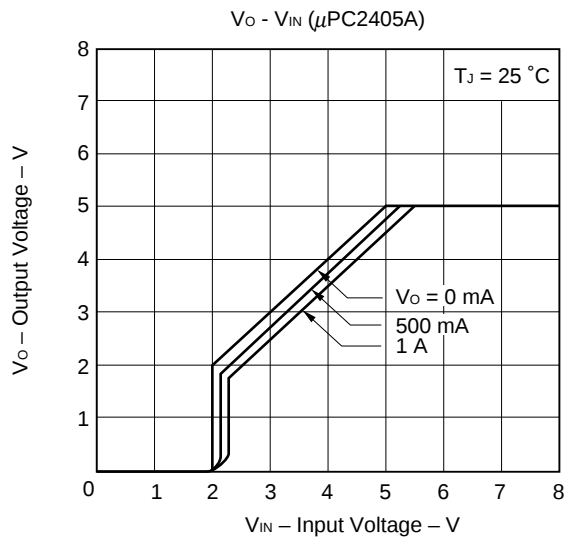
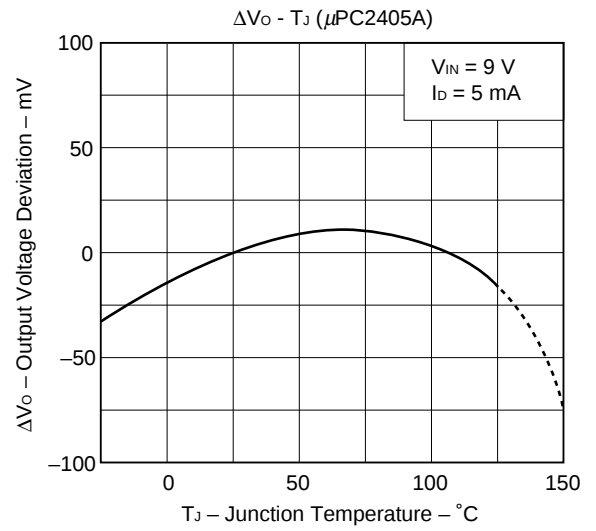
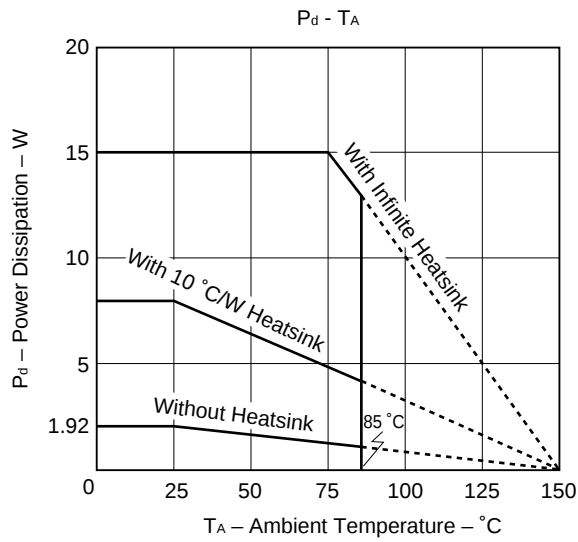
μPC2415A ($V_{IN} = 22\text{ V}$, $I_O = 500\text{ mA}$, $T_J = 25\text{ }^{\circ}\text{C}$, Unless otherwise specified)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Output Voltage	V_O	14.7	15	15.3	V	
		14.55		15.45		$16\text{ V} \leq V_{IN} \leq 27\text{ V}$, $5\text{ mA} \leq I_O \leq 500\text{ mA}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
		14.55		15.45		$5\text{ mA} \leq I_O \leq 1\text{ A}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
Line Regulation	REG_{IN}		18	150	mV	$17\text{ V} \leq V_{IN} \leq 27\text{ V}$
Load Regulation	REG_L		9	150	mV	$5\text{ mA} \leq I_O \leq 1\text{ A}$
Quiescent Current	I_{BIAS}		2.5	3.2	mA	$I_O = 0$
			10	60		$I_O = 1\text{ A}$
Start-up Current	$I_{BIAS(S)}$			15	mA	$V_{IN} = 14.5\text{ V}$, $I_O = 0\text{ mA}$
				75		$V_{IN} = 14.5\text{ V}$, $I_O = 1\text{ A}$
Quiescent Current Change	ΔI_{BIAS}			20	mA	$17\text{ V} \leq V_{IN} \leq 27\text{ V}$, $I_O = 1\text{ A}$
Output Noise Voltage	V_n		290		μV_{rms}	$10\text{ Hz} \leq f \leq 100\text{ kHz}$
Ripple Rejection	$R \cdot R$	51	56		dB	$f = 120\text{ Hz}$, $17\text{ V} \leq V_{IN} \leq 27\text{ V}$
Dropout Voltage	V_{DIF}		0.5	1.0	V	$I_O = 1\text{ A}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$
Short Circuit Current	I_{short}		0.8		A	$V_{IN} = 27\text{ V}$
Peak Output Current	I_{Opeak}	1.55	2.2	3.0	A	
Temperature Coefficient of Output Voltage	$\Delta V_O / \Delta T$		1.6		mV/ $^{\circ}\text{C}$	$I_O = 5\text{ mA}$, $0\text{ }^{\circ}\text{C} \leq T_J \leq 125\text{ }^{\circ}\text{C}$

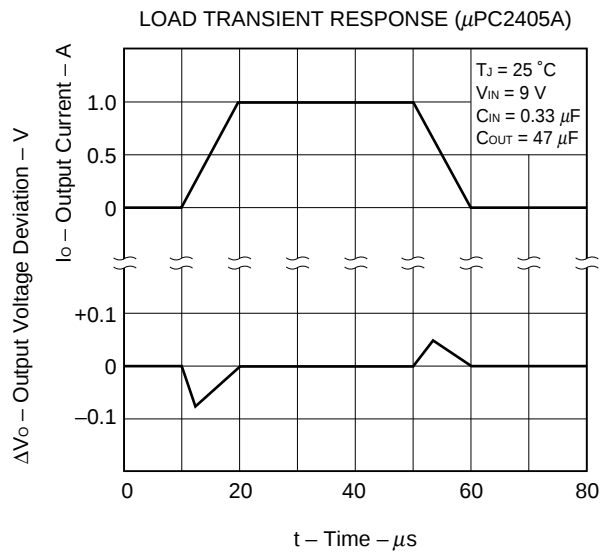
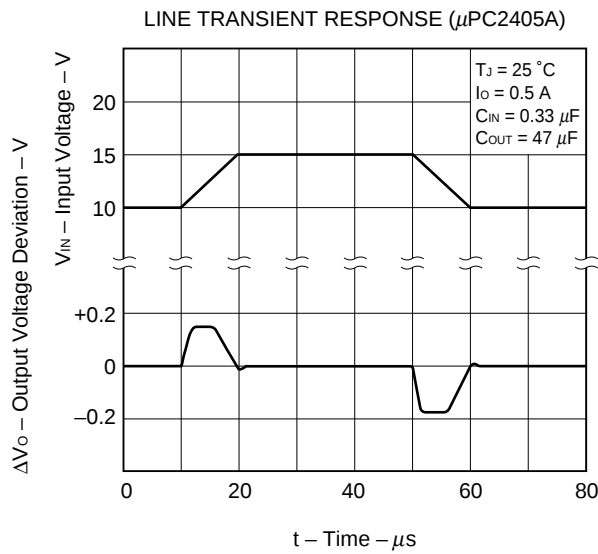
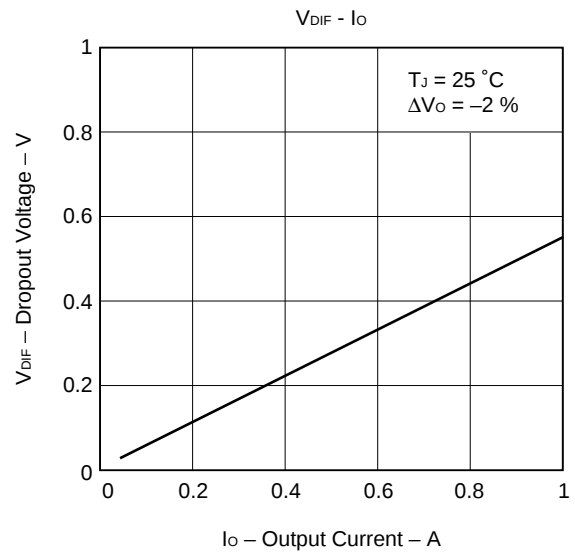
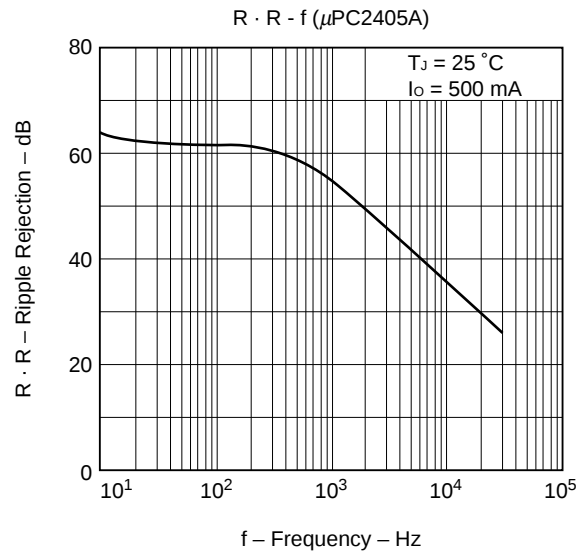
μPC2418A ($V_{IN} = 25\text{ V}$, $I_O = 500\text{ mA}$, $T_J = 25\text{ °C}$, Unless otherwise specified)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Output Voltage	V_O	17.64	18	18.36	V	
		17.46		18.54		$19\text{ V} \leq V_{IN} \leq 28\text{ V}$, $5\text{ mA} \leq I_O \leq 500\text{ mA}$, $0\text{ °C} \leq T_J \leq 125\text{ °C}$
		17.46		18.54		$5\text{ mA} \leq I_O \leq 1\text{ A}$, $0\text{ °C} \leq T_J \leq 125\text{ °C}$
Line Regulation	REG_{IN}		22	180	mV	$20\text{ V} \leq V_{IN} \leq 28\text{ V}$
Load Regulation	REG_L		11	180	mV	$5\text{ mA} \leq I_O \leq 1\text{ A}$
Quiescent Current	I_{BIAS}		2.5	3.2	mA	$I_O = 0$
			10	60		$I_O = 1\text{ A}$
Start-up Current	$I_{BIAS(S)}$			15	mA	$V_{IN} = 17.5\text{ V}$, $I_O = 0\text{ mA}$
				75		$V_{IN} = 17.5\text{ V}$, $I_O = 1\text{ A}$
Quiescent Current Change	ΔI_{BIAS}			20	mA	$20\text{ V} \leq V_{IN} \leq 28\text{ V}$, $I_O = 1\text{ A}$
Output Noise Voltage	V_n		350		μV_{rms}	$10\text{ Hz} \leq f \leq 100\text{ kHz}$
Ripple Rejection	$R \cdot R$	49	54		dB	$f = 120\text{ Hz}$, $20\text{ V} \leq V_{IN} \leq 28\text{ V}$
Dropout Voltage	V_{DIF}		0.5	1.0	V	$I_O = 1\text{ A}$, $0\text{ °C} \leq T_J \leq 125\text{ °C}$
Short Circuit Current	I_{Oshort}		0.8		A	$V_{IN} = 28\text{ V}$
Peak Output Current	I_{Opeak}	1.55	2.2	3.0	A	
Temperature Coefficient of Output Voltage	$\Delta V_O / \Delta T$		2.5		mV/°C	$I_O = 5\text{ mA}$, $0\text{ °C} \leq T_J \leq 125\text{ °C}$

TYPICAL CHARACTERISTICS



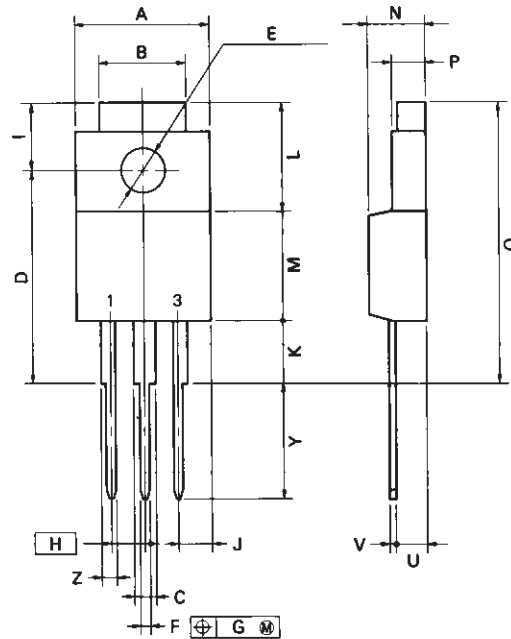
TYPICAL CHARACTERISTICS



PACKAGE DIMENSIONS (Unit: mm)

μPC2400AHF Series

3PIN PLASTIC SIP (MP-45G)



P3HF-254B-1

NOTE

Each lead centerline is located within 0.25 mm (0.01 inch) of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS	INCHES
A	10.4 MAX.	0.410 MAX.
B	7.0	0.276
C	1.2 MIN.	0.047 MIN.
D	17.0 ^{±0.3}	0.669 ^{+0.013} _{-0.012}
E	φ3.3 ^{±0.2}	φ0.130 ^{±0.008}
F	0.75 ^{±0.10}	0.030 ^{+0.004} _{-0.005}
G	0.25	0.010
H	2.54 (T.P.)	0.100 (T.P.)
I	5.0 ^{±0.3}	0.197 ^{±0.012}
J	2.66 MAX.	0.105 MAX.
K	4.8 MIN.	0.188 MIN.
L	8.5	0.335
M	8.5	0.335
N	4.5 ^{±0.2}	0.177 ^{±0.008}
P	2.8 ^{±0.2}	0.110 ^{+0.009} _{-0.008}
Q	22.4 MAX.	0.882 MAX.
U	2.4 ^{±0.5}	0.094 ^{+0.021} _{-0.020}
V	0.65 ^{±0.10}	0.026 ^{+0.004} _{-0.005}
Y	8.9 ^{±0.7}	0.350 ^{±0.028}
Z	1.0 MIN.	0.039 MIN.

RECOMMENDED SOLDERING CONDITIONS

The following conditions (see table below) must be met when soldering this product.

Please consult with our sales offices in case other soldering process is used, or in case soldering is done under different conditions.

TYPES OF THROUGH HOLE MOUNT DEVICE

μPC2400AHF Series

Soldering Process	Soldering Conditions	Symbol
Wave soldering	Solder temperature: 260 °C or below. Flow Time: 10 seconds or below.	

REFERENCE

Document Name	Document No.
NEC semiconductor device reliability/quality control system.	IEI-1212
Quality grade on NEC semiconductor devices.	IEI-1209
Semiconductor device mounting technology manual.	IEI-1207
Semiconductor device package manual.	IEI-1213
Guide to quality assurance for semiconductor devices.	MEI-1202
Semiconductor selection guide.	MF-1134

[MEMO]

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NEC devices are classified into the following three quality grades:

“Standard”, “Special”, and “Specific”. The Specific quality grade applies only to devices developed based on a customer designated “quality assurance program” for a specific application. The recommended applications of a device depend on its quality grade, as indicated below. Customers must check the quality grade of each device before using it in a particular application.

Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots

Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)

Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

The quality grade of NEC devices in “Standard” unless otherwise specified in NEC's Data Sheets or Data Books. If customers intend to use NEC devices for applications other than those specified for Standard quality grade, they should contact NEC Sales Representative in advance.

Anti-radioactive design is not implemented in this product.